## 54ACT11353, 74ACT11353 DUAL 1-OF-4 DATA SELECTORS/MULTIPLEXERS WITH 3-STATE OUTPUTS

SCAS045A - D3109, JUNE 1988 - REVISED APRIL 1993

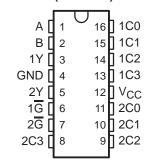
- Inverting Versions of 54ACT11253 and 74ACT11253
- Permits Multiplexing From N Lines to 1 Line
- Performs Parallel-to-Serial Conversion
- Inputs Are TTL-Voltage Compatible
- Flow-Through Architecture to Optimize PCB Layout
- Center-Pin V<sub>CC</sub> and GND Configurations to Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1-μm Process
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

#### description

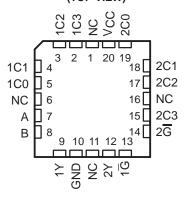
Each of these data selectors/multiplexers contains inverters and drivers to supply full binary decoding data selection to the AND-OR gates. Separate strobe inputs  $(\overline{G})$  are provided for each of the two four-line sections.

The 3-state outputs can interface with and drive data lines of bus-organized systems. With all but one of the common outputs disabled (at a high-impedance state), the low-impedance of the single enabled output will drive the bus line to a high or low logic level. Each output has its own strobe  $(\overline{G})$ . The output is disabled when its strobe is high.

54ACT11353 . . . J PACKAGE 74ACT11535 . . . D OR N PACKAGE (TOP VIEW)



54ACT11353 . . . FK PACKAGE (TOP VIEW)



The 54ACT11353 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The 74ACT11353 is characterized for operation from  $-40^{\circ}$ C to 85°C.

#### **FUNCTION TABLE**

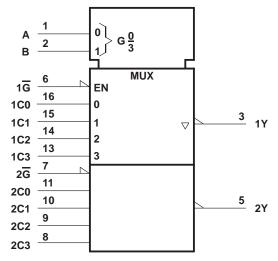
SELECT INPUTS			DATA I	NPUT	S	STROBE	OUTPUT		
В	Α	C0	C1	C2	C3		ı		
Х	Χ	Χ	Х	Х	Х	Н	Z		
L	L	L	Χ	Χ	Χ	L	Н		
L	L	Н	X	Χ	X	L	L		
L	Н	Х	L	Χ	X	L	Н		
L	Н	Χ	Н	X	Χ	L	L		
Н	L	Х	X	L	X	L	Н		
Н	L	Х	X	Н	X	L	L		
Н	Н	Х	Χ	Χ	L	L	Н		
Н	Н	Χ	Χ	Χ	Н	L	L		

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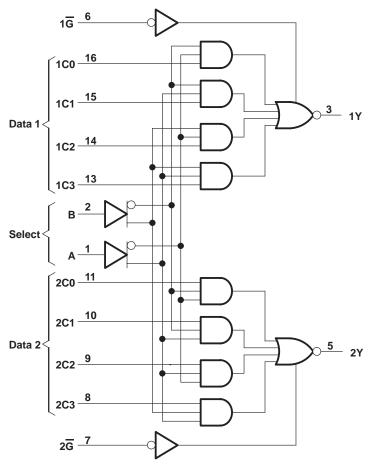
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# logic symbol†



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

# logic diagram (positive logic)



Pin numbers shown are for the D, J, and N packages.



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SCAS045A - D3109, JUNE 1988 - REVISED APRIL 1993

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	$-0.5$ V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	$\dots$ -0.5 V to V <sub>CC</sub> + 0.5 V
Output voltage range, V <sub>O</sub> (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ )	± 20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> )	$\dots \dots \pm 50 \text{ mA}$
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	$\dots \dots \pm 50 \text{ mA}$
Continuous current through V <sub>CC</sub> or GND	±100 mA
Storage temperature range	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### recommended operating conditions

		54ACT11353		74ACT	UNIT	
		MIN	MAX	MIN	MAX	UNII
Vcc	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
V <sub>IL</sub>	Low-level input voltage		0.8		0.8	V
٧ <sub>I</sub>	Input voltage	0	VCC	0	VCC	V
VO	Output voltage	0	VCC	0	VCC	V
IOH	High-level output current		-24		-24	mA
l <sub>OL</sub>	Low-level output current		24		24	mA
Δt/Δν	Input transition rise or fall rate	0	10	0	10	ns/V
TA	Operating free-air temperature	-55	125	- 40	85	°C

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SCAS045A - D3109, JUNE 1988 - REVISED APRIL 1993

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	T <sub>A</sub> = 25°C			54ACT11353		74ACT11353		UNIT	
PARAMETER	TEST CONDITIONS	vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
	JOH - 50 WA	4.5 V	4.4			4.4		4.4		٧	
	ΙΟΗ = – 50 μΑ	5.5 V	5.4			5.4		5.4			
\/-··	I <sub>OH</sub> = – 24 mA	4.5 V	3.94			3.7		3.8			
VOH	10H = - 24 IIIA	5.5 V	4.94			4.7		4.8		V	
	$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V				3.85					
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V						3.85			
	I <sub>OL</sub> = 50 μA	4.5 V			0.1		0.1		0.1	V	
	ΙΟΣ = 30 μΑ	5.5 V			0.1		0.1		0.1		
\/-·	I <sub>OL</sub> = 24 mA	4.5 V			0.36		0.5		0.44		
VOL	10L - 24 IIIA	5.5 V			0.36		0.5		0.44		
	$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V					1.65				
	I <sub>OL</sub> = 75 mA <sup>†</sup>	5.5 V							1.65		
loz	V <sub>O</sub> = V <sub>CC</sub> or GND	5.5 V			± 0.5		± 10		±5	μΑ	
lį	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1		±1	μΑ	
lcc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		160		80	μΑ	
Δl <sub>CC</sub> ‡	One input at 3.4 V, Other inputs at GND or V <sub>CC</sub>	5.5 V			0.9		1		1	mA	
Ci	$V_I = V_{CC}$ or GND	5 V		3.5						pF	
Со	$V_O = V_{CC}$ or GND	5 V		8						pF	

T Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T <sub>A</sub> = 25°C			54ACT11353		74ACT11353		UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t <sub>PLH</sub>	A or B	Any Y	1.5	6.6	11.1	1.5	13.8	1.5	12.7	ns
<sup>t</sup> PHL	AOIB		1.5	5.9	8.3	1.5	10.1	1.5	9.4	
t <sub>PLH</sub>	Data (Any C)	Any Y	1.5	6.3	9.8	1.5	12.3	1.5	11	
t <sub>PHL</sub>			1.5	5.3	7.2	1.5	10.5	1.5	8	115
<sup>t</sup> PZH	G	Any Y	1.5	4.3	6.8	1.5	7.9	1.5	7.4	
t <sub>PZL</sub>	5		1.5	4.2	6.7	1.5	7.8	1.5	7.4	ns
<sup>t</sup> PHZ	G	Any Y	1.5	6.1	7.8	1.5	8.6	1.5	8.2	ns
t <sub>PLZ</sub>	5		1.5	5.4	6.9	1.5	7.6	1.5	7.3	115

# operating characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

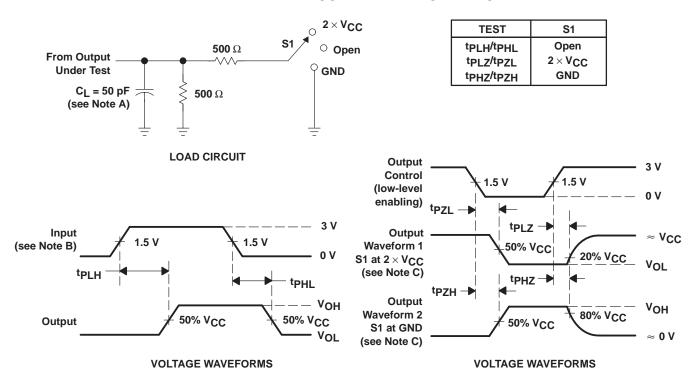
	PARAMETER	TEST CONDITIONS	TYP	UNIT	
C .	Power dissipation capacitance per multiplexer	Outputs enabled	C: _ 50 pE	39	pF
Cpd		Outputs disabled	$C_L = 50 \text{ pF},  f = 1 \text{ MHz}$	19	PΓ



<sup>&</sup>lt;sup>‡</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V to V<sub>CC</sub>.

SCAS045A - D3109, JUNE 1988 - REVISED APRIL 1993

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f = 3 \text{ ns}$ ,  $t_f = 3 \text{ ns}$ .
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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